Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination	
10786609	NAKANO ET AL.	
Examiner	Art Unit	
Nguyen, Jennifer T	2629	

SEARCHED							
Class	Subclass	Date	Examiner				
345	93-96,87,89-92,89,100,204,212,690-692	8/4/06	JN				

SEARCH NOTES					
Search Notes	Date	Examiner			
East search, PAJ	8/4/06	JN			

INTERFERENCE SEARCH						
Class	Subclass	Date	Examiner			

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